

Search Notes

Application/Control No.

10/535,715

Applicant(s)/Patent under
Reexamination

IWAYAMA ET AL.

Examiner

HUYEN D. LE

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner
381	87, 337, 339, 340, 341, 342	8/14/2007	HL
381	343	8/14/2007	HL
381	346	8/14/2007	HL
381	347	8/14/2007	HL
381	160	8/14/2007	HL
381	162	8/14/2007	HL
381	165	8/14/2007	HL
381	386	8/14/2007	HL
381	391	8/14/2007	HL
381	189	8/14/2007	HL
181	148	8/14/2007	HL
181	155-156	8/14/2007	HL
181	175	8/14/2007	HL
181	184-185	8/14/2007	HL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as above	8/14/2007	HL	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR